Intrinsic and complex defect engineering of quasi-one-dimensional ribbons Sb₂S₃ for photovoltaics performance

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 Sb_2S_3 has attracted great attention recently as a prospective solar cell absorber material. In this work, intrinsic defects, dopants, and their complexes in Sb_2S_3 are systematically investigated by using hybrid functional theory. V_{Sb} and V_S are dominant native defects and pin the Fermi level near the midgap, which is consistent with the high resistivity observed experimentally. Both V_{Sb} and V_S introduce deep levels inside the band gap, which can trap free carriers. Our calculated deep transition levels of V_{Sb} and Sb_S are consistent well with the results of the deep-level transient spectroscopy measurement. We further study dopants (including Cu, Ti, Zn, Br, and Cl) in Sb_2S_3 and find that Zn and Br/Cl are shallow acceptors and donors, respectively, which may be used to control the carrier and trap densities in Sb_2S_3 . In addition, the defect complexes, i.e., $Cu(Zn)_{Sb} + V_S$ and $Cl(Br)_S + V_{Sb}$ are also investigated. The interaction between the donor and acceptor defects makes the defect levels of complexes shallower and less detrimental to carrier transport.

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I. INTRODUCTION

High-efficiency, earth-abundant, and nontoxic solar materials are indispensable in photovoltaics (PV) technologies. In the last few decades, solar cell absorber materials such as silicon [1], CdTe [2], Cu(In,Ga)Se₂ (CIGS) [3,4], and organic-inorganic hybrid perovskites (e.g., CH₃NH₃PbI₃) [5] have drawn extensive attention because of their impressive certified efficiencies. However, there are still some inevitable shortcomings that limit their performance as solar cell materials. For example, silicon has poor optical absorption; thus, large crystals are required in a Si solar cell [6,7]. For secondgeneration solar cells, CdTe contains toxic heavy metals and suffers from a relatively low open-circuit voltage (V_{OC}) [8] while CIGS has complex defect problems that appear to limit any significant improvements in cell efficiency [9]. For the hybrid organic-inorganic lead halide perovskites, their air and thermal instability as well as toxicity remain challenging for practical applications [10,11].

Antimony sulfide, Sb₂S₃, is a low-cost, earth-abundant, nontoxic, and air-stable material, which has attracted much attention recently as a solar cell material [12,13]. Compared with other metal-chalcogenide PV materials, high-quality Sb₂S₃ films can be synthesized at low temperatures <350 °C because it has a relatively low melting point of 550 °C [14]. As for its crystal structure, Sb₂S₃ has a pseudo-one-dimensional (1D) structure without dangling bonds or surface states. Therefore, grain boundaries are expected to be electrically benign, incurring a low recombination loss or V_{OC} loss, similar to 1D Sb₂Se₃ [15]. In addition, several studies have also demonstrated that the carrier diffusion length in Sb₂S₃ is on the order of a few hundred nanometers (290–900 nm) [16,17], longer than the thickness of the Sb₂S₃ layer (80–200 nm) in solar cells [18–20]. By engineering the surface defects during the chemical bath deposition of the ultrathin Sb₂S₃ absorber layer, Seok *et al.* obtained 7.5% power conversion efficiency (PCE) in mesoporous sensitized solar cells [19]. A PCE of 6.56% was also achieved in a planar heterojunction solar cell recently [20]. Sb₂S₃ has a band gap of 1.7–1.8 eV [18,21–24] and thus can be used as the top cell in a tandem dual-junction solar cell with an expected higher PCE exceeding 40% [25].

By systematically investigating the carrier recombination kinetics, Dennler *et al.* showed that the relatively low PCE of Sb₂S₃ solar cells is related to the large recombination rate in Sb₂S₃ itself, likely caused by the defect-induced sub-gap states [16]. High resistivity in Sb₂S₃ films (5.0×10^6 and $1.0 \times 10^8 \Omega$ cm for *n*- and *p*-type conductivities, respectively) was observed [18,26], suggesting the possibility of strong defect compensation. Therefore, a comprehensive understanding of defect properties (especially those of deep traps) and an improved defect management are important for the further optimization of Sb₂S₃ solar cells.

Despite the significant progress made in Sb_2S_3 solar cell recently, the understanding of the defect physics in Sb_2S_3 is still limited [27,28]. In this paper, hybrid density-functional theory calculations are performed to study the electronic structure as well as properties of intrinsic defects, impurities, and defect complexes in Sb_2S_3 . Our results show that V_{Sb} and V_S are the dominant defects in Sb_2S_3 and introduce deep states in the band gap. Impurities are investigated for their effects in modifying trap and free carrier densities. Our results show that Zn_{Sb} and Cl_S are much shallower than vacancies (V_{Sb} and V_S) and defect complexes can also effectively make the deep defect levels shallower and less detrimental to carrier

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transport. Based on our theoretical results, guidelines for further development of Sb_2S_3 -based solar cells with improved performance are proposed.

II. COMPUTATIONAL METHODS

Our calculations are based on the Heyd-Scuseria-Ernzerhof hybrid functional [29] implemented in the Vienna Ab initio Simulation Package (VASP) [30,31]. The mixing parameter for the nonlocal Hartree-Fock exchange is set to be 0.25, which yields a band gap of 1.76 eV, which is consistent with experimental indirect band gap of 1.74 eV [22]. The cutoff energy for the plane-wave basis was set at 400 eV and the atomic positions were fully relaxed until the residual forces are less than 0.01 eV/Å. The Brillouin-zone integration is sampled by setting a $2 \times 8 \times 2$ Γ -centered *k*-point mesh for the 20-atom primitive cell and a $2 \times 2 \times 2$ Monkhorst-Pack k-point mesh for the $1 \times 3 \times 1$ Sb₂S₃ supercell (60 atoms) in the simulation of defect properties. The experimental lattice parameters (a =11.3107 Å, b = 3.8363 Å, and c = 11.2285 Å [32,33], space group *Pnma*) are used in all calculations. Based on our tests using larger supercells, the errors in transition levels are less than 0.1 eV.

The defect formation energy with a charge q is evaluated by

$$\Delta H_{D,q}(\varepsilon_f, \mu_\alpha) = (E_{D,q} - E_H) - \sum_\alpha n_\alpha \left(E_\alpha^{\text{ref}} + \mu_\alpha \right) + q(\varepsilon_{\text{VBM}} + \varepsilon_f), \tag{1}$$

where $E_{D,q}$ is the total energy of a supercell containing the defect D with a charge q and E_H is the energy of a defect-free cell. n_{α} represents the number of exchanged atom, E_{α}^{ref} is the chemical potential of the α th element in its bulk or gas form, and μ_{α} is the chemical potential of the α th element referenced to E_{α}^{ref} . E_{VBM} is the energy of the valence-band maximum (VBM) of the host. ε_f is the Fermi level referenced to the VBM. We also applied the image charge correction for charged defects/impurities and the potential alignment correction, which account for the finite-size effects in the supercell calculation of defects [34,35].

The transition level of a defect, $\varepsilon(q/q')$, corresponding to a change in its charge state between q and q', is given by the Fermi level, at which the formation for charge state q and q' equals each other:

$$\varepsilon(q/q') = (\Delta H_{D,q} - \Delta H_{D,q'})/(q'-q).$$
⁽²⁾

In order to get stable Sb_2S_3 and avoid the elemental phases of Sb or S under equilibrium growth conditions, the chemical potentials of Sb and S should satisfy the following restriction:

$$\mu_{Sb} \leqslant 0,$$

$$\mu_{S} \leqslant 0,$$

$$\mu_{Sb} + 3\mu_{S} = \Delta H_{f}(Sb_{2}S_{3}) = -1.07\text{eV},$$
(3)

where $\Delta H_f(\text{Sb}_2\text{S}_3)$ is the heat of formation of Sb_2S_3 . At the Sb-rich limit, $\mu_{\text{Sb}} = 0 \text{ eV}$ and $\mu_{\text{S}} = -0.357 \text{ eV}$, while at the S-rich limit, $\mu_{\text{Sb}} = -0.535 \text{ eV}$ and $\mu_{\text{S}} = 0 \text{ eV}$. The formation energies of Cu, Zn, Cs, Ti, Cl, and Br impurities are also considered at above Sb- and S-rich limits.

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III. RESULTS AND DISCUSSION

A. Electronic properties of Sb₂S₃

Sb₂S₃ crystallizes in an orthorhombic structure at room temperature and under atmospheric pressure. The optimized geometry of Sb_2S_3 is shown in Fig. 1(a). The 1D Sb_2S_3 chain is along the b axis. There are three and two nonequivalent crystallographic sites for S and Sb, respectively. Sb1, S2, and S3 are threefold coordinated, Sb2 is fivefold coordinated, and S1 is twofold coordinated. This structure has complex coordination environments with mixed covalent and ionic bond character. Our calculated orbital decomposed density of states [Fig. 1(b)] of Sb₂S₃ shows that the electronic states near the VBM are mainly formed by S 3p and Sb 5s orbitals, while those near the conduction-band minimum (CBM) consist of mainly Sb 5p and a small contribution from S 3p orbitals. The hybridization between S 3p and Sb 5s states makes the top valence band more dispersive as demonstrated by the calculated small hole effective mass shown below. The hybrid density-functional calculation shows that the band gap of Sb_2S_3 is indirect with value of 1.76 eV [Fig. 1(c)], which is consistent well with the experimentally measured values [22,24] and other calculated results [36,37]. The band structure of Sb₂S₃ shows that Sb₂S₃ has an indirect band gap with the VBM at Γ point and the CBM located along the Γ -Z line and close to the Z point. Our calculated energy difference of the lowest conduction band between C and Z points is only 3 meV. Our calculated direct band gaps at Γ , C, and Z points are 1.98, 1.91, and 1.92 eV, respectively. The calculated optical absorption coefficients of Sb₂S₃ are also shown in Fig. 1(d). Note that, the cross band-gap optical transitions include the efficient onsite transitions between Sb 5s and Sb 5plevels, which should contribute to the experimentally observed high absorption coefficient [38–40]. Our calculated optical absorption coefficients show that it can achieve 10^4 cm^{-1} at the photon energy of 2.04 eV, which is consistent with the experimental conclusion that absorption coefficients can reach 10^{4} - 10^{5} cm⁻¹ for photo energies larger than band gap E_{g} [38-40].

According to our calculated band structure of Sb₂S₃, the top valence band is dispersive along all three crystallographic axes, while the low conduction band is only dispersive along the $\Gamma - Z$ direction (c axis) close to CBM and the $\Gamma - X$ direction (b axis); the low conduction band along the $\Gamma - Y$ direction (a axis) is very flat, indicating anisotropic electron transport. In Sb₂S₃, our calculated average effective mass of hole is $0.17 m_0$ around VBM $(m_h^{\Gamma-X} = 0.11 m_0, m_h^{\Gamma-Z} =$ $0.20 m_0, m_h^{\Gamma-Y} = 0.21 m_0$, which is smaller than the average effective mass of electron 0.28 m_0 around CBM ($m_e^{C-\Gamma}$ = $0.25 m_0, m_e^{C-Z} = 0.30 m_0$; here C donates the k point where CBM locates). The small hole effective masses are comparable to those in other good solar absorber materials such as Si $(0.19 m_0)$ [41], CdTe $(0.11 m_0)$ [42], CuZnSnS₂ $(0.23 m_0)$ [41], and MAPbI₃ $(0.28 m_0)$ [43]. Thus, Sb₂S₃ can be an excellent hole transport material in a thin-film solar cell.

B. Native point defects in Sb₂S₃

There are three and two nonequivalent crystallographic sites for S and Sb, respectively. We consider point defects on



FIG. 1. (a) The crystal structure of 20-atom Sb_2S_3 unit cell with yellow and purple balls representing S anions and Sb cations, respectively, (b) partial density of states (DOS), (c) band structure, and (d) optical absorption coefficients of Sb_2S_3 . The inset at (c) shows the conduction band near the CBM (the *C* point).

all nonequivalent sites as shown in Fig. 1(a), i.e., (i) sulfur vacancy (V_{S1} , V_{S2} , V_{S3}), (ii) cation vacancy (V_{Sb1} and V_{Sb2}), (iii) the anion replace cation antisite (S_{Sb1} and S_{Sb2}), (iv) cation replace anion antisite (Sb_{S1} , Sb_{S2} , and Sb_{S3}), (v) S interstitial (S_i), and (vi) Sb interstitial (Sb_i).

Formation energies of all defects as a function of the Fermi level under both Sb- and S-rich conditions are shown in Fig. 2. As can be seen, the most important native defects in Sb_2S_3 are vacancies, i.e., V_{Sb} , acting as an acceptor, and V_S , acting as a donor. The defects with low formation energies should



FIG. 2. Calculated intrinsic defect formation energies in Sb_2S_3 under (a) S- and (b) Sb-rich conditions. A transition level is where the slope of a formation energy line changes.

play dominate roles in transport properties. In the absence of a high concentration of impurities, the Fermi level should be close to the crossing point of the formation energy lines for the lowest-energy native donor and acceptor defects. For both S- and Sb rich conditions, the Fermi level is close to mid gap ($\varepsilon_{VBM} + 0.85 \text{ eV}$ and $\varepsilon_{VBM} + 1.03 \text{ eV}$, respectively, crossing point of formation energy lines of V_{S2} and V_{Sb1}), which is consistent with the measured high resistivity of 1.0×10^8 or $5.0 \times 10^6 \Omega \text{ cm}$ in Sb₂S₃ thin films with *p*- or *n*-type conductivity [18,26].

V_S is the main donor defect in Sb₂S₃ under both S- and Sb-rich conditions, which accords well with the common phenomenon that the anion vacancy is usually a low-energy donor defect in compound semiconductors [44]. The formation energies of V_S on the three S sites are slightly different. V_{S2} is the most stable followed by V_{S1} and V_{S3} . Interestingly, V_{S2} is a shallow donor while V_{S1} and V_{S3} are both deep donors. The transition level $\varepsilon(0/2+)$ for V_{S1} and V_{S3} are located at 1.18 and 1.00 eV above the VBM, respectively. The shallow nature of V_{S2} is likely related to the relatively long Sb-Sb distance around V_{S2}. In defect-free Sb₂S₃, the average Sb-Sb distances around S1, S2, and S3 are 3.84, 3.95, and 3.88 Å, respectively. For 2+ charged V_{S1} , V_{S2} , and V_{S3} , the average Sb-Sb distances around the vacancy are increased to 4.20, 4.53, and 4.19 Å, respectively, due to the Coulomb repulsion. The neighboring Sb atoms around the S vacancy are able to move toward the center of the vacancy to enhance the Sb-Sb hybridization and trap two electrons, forming neutral V_{S1} and V_{S3}. Such deep electron trapping and the associated structural relaxation are energetically unfavorable for V_{S2} as a result of the long Sb-Sb distance; thus, only shallow trapping at a hydrogenic level is possible.

Sb vacancies (V_{Sb}) are also dominant defects in Sb_2S_3 . Figure 2 shows that, between the two Sb sites, V_{Sb1} is more stable and both V_{Sb1} and V_{Sb2} introduce deep hole-trapping levels, which are detrimental to hole transport efficiency. Compared with V_S and V_{Sb}, antisites S_{Sb} and Sb_S have higher formation energies under both Sb-and S-rich growth conditions. For the cation interstitial (Sb_i) or anion interstitial (S_i) in Sb₂S₃, six different interstitial sites are constructed. Sb_i and S_i donor defects possess deep transition levels, which can act as charge recombination centers. However, their formation energies are high at the Fermi pinning level, indicating that their effect on conductivity should be minimal. Note that in Sb_2Se_3 [45,46], except vacancies V_{Sb} and V_{Se} , antisites Sb_{Se} and Se_{Sb} can also be the lowest-energy defects possibly due to the small size difference between Sb and Se. The high formation energies of antisite defects in Sb₂S₃ is likely due to the larger size difference between Sb and S, and this trend is more obviously in Bi_2S_3 [47]. This atomic size difference between Bi, Sb and S, Se, and Te have significant influence on the properties of antisite defects like formation energy and transition level.

Figure 3 presents our calculated transition energy levels of the above native defects in Sb_2S_3 . Our results show that all defects except V_{S2} introduce deep traps. Deep-level transient spectroscopy (DLTS) is a powerful technique to characterize the properties of defects [48–50]. Several DLTS measurements have been performed for Sb_2Se_3 and $Sb_2(S, Se)_3$ alloys,



FIG. 3. Transition energy levels of intrinsic defects on different atomic sites in the band gap of Sb_2S_3 .

while for pristine Sb_2S_3 there are only a few reports. One deep acceptor level (H1) at 0.52 eV above the VBM was observed in Sb_2S_3 by DLTS [51]. On the other hand, three hole traps (H1, H2, and H3) located at 0.507, 0.689, and 0.762 eV above the VBM were observed in $Sb_2(S_{1-x}Se_x)_3$ with x = 0 and x = 0.17. Increasing the Se concentration to x = 0.29 (0.48), only two hole traps at 0.502 and 0.766 (0.490 and 0.768) eV were found [52]. The different hole-trapping levels reported in Refs. [51,52] may be related to different growth environments. Wen *et. al.* observed the two hole traps located at 0.48 ± 0.07 (0.49 ± 0.03) and 0.71 ± 0.02 (0.74 ± 0.04) eV above VBM and one electron trap at 0.61 ± 0.03 (0.60 ± 0.02) eV below the CBM in Sb₂Se₃ sample processed by vapor transport deposition (rapid thermal evaporation) method [53]. Ma et al. also found two hole traps at Ev + 0.48 eV and Ev + 0.71 eV and one electron trap level (E1) at Ec - 0.63 eV in Sb₂Se₃; these trap levels remain nearly the same after doping by 5.23% S [54]. The two hole traps were attributed to V_{Sb} and Sb_{Se} , respectively, and the electron trap was assigned to Se_{Sb} [53]. For comparison, our calculated hole-trapping levels of (-/2-)for V_{Sb1} , (-/2-) for V_{Sb2} , and (2-/3-) for V_{Sb2} in Sb_2S_3 are 0.75, 0.52, and 0.63 eV, respectively, which are in good agreement with those measured by DLTS [52]. In addition, our calculated (0/-) levels for Sb_{S1}, Sb_{S2}, and Sb_{S3}, which are 0.48, 0.45, and 0.47 eV above the VBM, respectively, are also very close to those measured by DLTS [52]. Thus, both V_{Sb} and Sb_S may account for the observed hole traps in DLTS measurements. Note that Sb_S is a negative-U center; neutral Sb_S is metastable and thus the (0/-) levels of Sb_S are not shown in Figs. 2 and 3 (see all the transition levels of vacancies and antisites for Sb₂S₃ in the Supplemental Material [55]). Only the stable charge states of +1 and -1 for Sb_S are shown in Figs. 2 and 3. The (0/-) level is a single holetrapping level, which is compared with the DLTS-observed hole-trapping levels as discussed above. For the negative-U defect, the conventional DLTS transient is determined by the first slower emission process, another faster emission follows immediately. If biased injection is replaced by the optical injection, both of the emission processes can be observed. Considering the thermal barrier associated with the transition level, the slower emission corresponds to the transition with deeper level reference to CBM or VBM.

Next, we investigate impurities and their complexes with native defects for their potential effects on trap levels and densities.



FIG. 4. Calculation of the dopant formation energies in Sb_2S_3 under S-rich and Sb-rich growth conditions. A transition level is where the slope changes.



FIG. 5. The transition levels of different impurities and defect complexes in Sb₂S₃.

C. Impurities and defect complexes in Sb₂S₃

The above results show that an intrinsic Sb_2S_3 film should have high resistivity with *p*- or *n*-type conductivity under Sand Sb-rich conditions, respectively. In most of Sb_2S_3 solar cells, Sb_2S_3 shows *n*-type conductivity [20]. To control the carrier transport in Sb_2S_3 , extrinsic dopants (including Zn, Cu, Ti, Br, and Cl) and their complexes with native defects are investigated.

 Zn_{Sb} and Cu_{Sb} both act as acceptors; the former is shallow while the latter is deep. The formation energies of Zn_{Sb} and Cu_{Sb} together with V_{Sb} and V_S are shown in Fig. 4 under both Sb- and S-rich conditions. Compared to undoped Sb_2S_3 , the Fermi level is lower in energy close to the crossing point of formation energies line of Zn_{Sb} (Cu_{Sb}) acceptor and V_S donor, resulting in higher hole density. For example, under the S-rich condition the crossing point determined by Zn_{Sb1} (Cu_{Sb1}) and V_{S2} locates at 0.56 (0.57) eV above the VBM, lower than that of 0.85 eV in undoped Sb_2S_3 . A lower Fermi level suppresses the formation of V_{Sb} deep acceptors but increases the density of V_S donor defects. For the deep acceptor Cu_{Sb} , the (-/2-) transition levels of Cu_{Sb1} and Cu_{Sb2} are 0.70 and 0.50 eV above VBM, respectively, as shown in Fig. 5.

For *n*-type doping, our results show that Ti_{Sb} is a donor with deep (0/+) ionization energy levels of 0.55 and 0.61 eV below the CBM for the Sb1 and Sb2 sites, respectively. On the other hand, both Cl_S and Br_S have shallow donor levels. Because the size difference between Cl and S is smaller than that between Br and S, the formation energy of Cl_S is lower than that of Br_S (only results of Cl are presented in Fig. 4). The (0/+) transition levels for Cl_{S1} and Cl_{S3} are 0.04 and 0.09 eV below the CBM, respectively, while for Cl_{S2} it is somewhat deep at 0.15 eV. For Br_{S1} , the (0/+) transition level is 0.03 eV, while for Br_{S2} and Br_{S3} , the transition levels are 0.18 and 0.24 eV, respectively. Cl doping can raise the Fermi level; for example, under the Sb-rich conduction, the Cl-doped Sb₂S₃ has the Fermi level close to 1.19 eV above the VBM (determined by V_{Sb1} and Cl_{S1}) as shown in Fig. 4, higher than that of 1.03 eV above the VBM (determined by V_{Sb1} and V_{S2}) in undoped Sb₂S₃.

Dopants can bind with native defects, forming defect complexes, and modify the defect level position. The dopant-defect coupling can potentially make a defect shallower [9]. Here we mainly focus on some chosen donor-acceptor complexes, such as $Cu_{Sb} + V_S$, $Zn_{Sb} + V_S$, and $Cl_S + V_{Sb}$. In these complexes, the dopant and the defect are chosen to be nearest neighbors for enhancing their coupling strength. The goal is to make the deep V_S and V_{Sb} defects shallower, i.e., less harmful to carriers transport. The fully passivated complexes $2Zn_{Sb} + V_S$ and $3Cl_S + V_{Sb}$ are also studied.

Cu_{Sb} acceptor can easily bind with a V_S donor, forming a neutral Cu_{Sb} + V_S complex. The electrons of V_S transfer to the Cu_{Sb}. Our calculated (-/0) and (0/+) transition levels of Cu_{Sb1} + V_{S1} are located at 0.04 below the CBM and 0.16 eV above the VBM, respectively, which are shallower than the (2+/+) electron-trapping level of (V_{S1})⁺ and the (2-/-) hole-trapping level of (Cu_{Sb1})⁻. These levels are much shallower than those of the isolated defects because the donor-acceptor coupling pushes the electron and



FIG. 6. Effects of Cu_{Sb1} - V_{S1} binding on the electron-trapping level of V_{S1} and the hole-trapping level of Cu_{Sb1} . (a) and (d) show the (2+/+) electron trapping level of V_{S1} and the charge density of the trapped electron at $(V_{S1})^+$, respectively; (b) and (e) show the (2-/-) hole trapping level of Cu_{Sb1} and the charge density of the trapped hole at $(Cu_{Sb1})^-$, respectively; (c) shows the (0/-) electron-trapping and the (+/0) hole-trapping levels of $Cu_{Sb1} + V_{S1}$; and (f) shows the trapped electron at $(Cu_{Sb1} + V_{S1})^-$ (upper panel) and the trapped hole at $(Cu_{Sb1} + V_{S1})^+$ (lower panel).

hole-trapping levels away from each other. As a result, the electronic trapping level is closer to the CBM and the holetrapping level is closer to the VBM, as shown in Fig. 5. To demonstrate this more clearly, the charge densities are also plotted in Fig 6. As we can see, the charge densities of isolated V_{S1} and Cu_{Sb1} are localized around the S vacancy and Cu_{Sb1}, respectively, while the charge density of the $Cu_{Sb1} + V_{S1}$ complex is much more delocalized, which accords well with the deep and shallower levels we obtained. Furthermore, $Cu_{Sb1} + V_{S1}$ has a binding energy -0.72 eV, which indicates that the complexes are not easy to dissociate once they are formed under growth conditions. As for the most stable $Cu_{Sb} - V_S$ complex, i.e., $Cu_{Sb2} + V_{S3}$, its defect levels also become shallower than those of the isolated defects. Their (0/-) and (0/+) transition levels are $E_{\text{CBM}} - 0.08 \text{ eV}$ and $E_{\text{VBM}} + 0.39 \,\text{eV}$, which are shallower than the (0/2+)transition level of V_{S3} and the (-/-2) transition level of Cu_{Sb2}, which are $E_{CBM} - 0.76$ and $E_{VBM} + 0.50 \text{ eV}$, respectively. For complexes $Cu_{Sb1} + V_{S2}$ and $Cu_{Sb2} + V_{S2}$, since isolated V_{S2} itself is a shallow donor, the coupling between a delocalized donor level and a localized acceptor level is not as strong as between two localized levels. The (0/+) levels of $Cu_{Sb1} + V_{S2}$ and $Cu_{Sb2} + V_{S2}$ are a little deeper than those of $Cu_{Sb1} + V_{S1}$ and $Cu_{Sb2} + V_{S3}$.

A V_S donor can also bind with a Zn_{Sb} acceptor, resulting in a Zn_{Sb} + V_S complex. For the (0/+) transition level of Zn_{Sb1} + V_{S1} is at 0.53 eV below CBM, similar to the (+/2+) level of V_{S1} at 0.60 eV below the CBM. For Zn_{Sb1} + V_{S2} and Zn_{Sb2} + V_{S2}, their (0/+) levels are at 0.09 and 0.18 eV below the CBM, respectively, relatively deeper than the (+/2+) level of V_{S2} at 0.02 eV below the CBM, due to the structure distortion introduced by the substitution of Sb by Zn in the complex. For Zn_{Sb2} + V_{S3}, its (0/+) level is at 0.29 eV below the CBM, much shallower than the (0/2+) level of V_{S3} at



FIG. 7. Calculated formation energies of different defect complexes in Sb_2S_3 under S-rich and Sb-rich growth conditions. A transition level is the Fermi level where the slope of a formation energy line changes.

0.76 eV below the CBM, while similar to the (+/2+) level of V_{S3} at 0.30 eV below the CBM (this level is unstable and not shown in Figs. 3 and 5). Our above results demonstrate that the delocalization character of Zn_{Sb} leads to the weak interaction between Zn_{Sb} and V_S in partially passivated complex Zn_{Sb} + V_S. The fully passivated complex $2Zn_{Sb1} + V_{S1}$ is also studied and no localized states are found.

Donor defect Cl_S , can also bind to the acceptor defect V_{Sb} , forming complexes $Cl_S + V_{Sb}$. For $Cl_{S3} + V_{Sb2}$, the (-/2-)level at 0.26 eV is much shallower than the (2-/3-) level of V_{Sb2} at 0.63 eV, and for $Cl_{S2} + V_{Sb1}$, the (-/2-) level at 0.17 eV is also shallower than the (-/3-) level of V_{Sb1} at 0.48 eV (unstable (2-/3-) level of V_{Sb1} at 0.21 eV). For the fully passivated complex $3Cl_S + V_{Sb1}$, the (0/+) and (0/-) levels are 0.04 and 0.08 eV, respectively, which are less harmful to the carrier transport.

When two defects bind to form a defect complex, the formation energy may be lowered through interactions like charge compensation, subsequent Coulomb attraction, and atomic relaxation driven by strain relief [9]. Therefore, the position of Fermi level pinned by donor and acceptor defects with lowest formation energies may be changed after considering the effect of defect complexes. Figure 7 plots the formation energies of different defect complexes along with native defects studied above. For Cu doping shown in Figs. 7(a) and 7(b), in the case of S rich, the Fermi level is close to 0.57 eV above the VBM determined by V_{S2} and Cu_{Sb1}. For Zn doping, in the case of S rich, the Fermi level is close to 0.65 eV above VBM determined by Zn_{Sb1} and complex $Zn_{Sb1} + V_{S2}$. For Cl doping, in the case of Sb rich, the Fermi level is close to 1.10 eV above the VBM determined by Cl_{S1} and complex $Cl_{S2} + V_{Sb1}$. Therefore, compared with



FIG. 8. The experimental energy level of band edge vs vacuum of different photovoltaic semiconductor materials [56–59].

the Fermi level pinned by point defects, the Fermi level does not change much.

Our above results show that donor (such as Cl) and acceptor (such as Zn or Cu) doping can increase carrier density by moving the Fermi level and reduce the trapping energies at defects by forming complexes with native defects, leading to improved solar cell performance.

D. Band alignment with other materials

As shown in Fig. 8, the experimental band offset versus vacuum between different semiconductor materials used in solar cells is presented. Electrons from Sb₂S₃ [56] or Sb₂Se₃ [57] can be injected to ZnO [58], TiO₂ [56], or CdS [59], while holes are blocked. As shown above, chemical doping in Sb₂S₃ can modify the Fermi level and consequently changes the charge transfer and band offset at the interface with the electron-extracting layer, providing additional means to tune the charge separation and transport efficiencies. A Sb₂S₃ cell may also be coupled with a Si or Sb₂Se₃ cell to form a multijunction tandem cell. Considering the small hole effective mass and the intrinsically benign grain boundaries of Sb₂S₃, *p*-type Sb₂S₃ may also be used as a hole transport material in solar cells.

IV. CONCLUSION

In summary, electronic structure, native defects, dopants, and dopant-defect complexes in Sb₂S₃ are studied by hybrid density-functional theory calculations. The calculated small hole effective masses and strong optical absorption are favorable for photovoltaic applications. S and Sb vacancies are the dominate donor and acceptor defects with low formation energies in Sb_2S_3 and both introduce deep trapping levels, which are detrimental to carrier transport. We identified signals of deep-level transient spectroscopy for hole traps to vacancy Sb and antisite Sb_S. Chemical doping by shallow donors (e.g., Cl, Br) or shallow acceptors (e.g., Zn) can modify the Fermi level, resulting in a higher carrier density and providing means to fine-tune the properties of the interface with other components of the solar cell (such as the electron-extraction layer and the hole-transport layer). By complexing with native defects, Cl/Br and Zn dopants can also reduce the trapping energy of the native defects, improving the carrier transport efficiency. We hope that this work can serve as a useful guide to designing higher efficiency Sb₂S₃ photovoltaic devices.

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